

Automotive 0.5A Variable Output LDO Regulator

BD00IA5MHFV-M

General Description

BD00IA5MHFV-M is a LDO regulator with output current 0.5A. The output accuracy is $\pm 3\%$ between Ta=-40°C to +105°C. The variable output voltage can be varied from 0.8V to 4.5V using external resistors. It has package type: HVSOF6 which is small and good heat resistance. Over current protection (for protecting the IC destruction by output short circuit), circuit current ON/OFF switch (for setting the circuit 0 μ A at shutdown mode), and thermal shutdown circuit (for protecting IC from heat destruction by over load condition) are all built in. It is usable for ceramic capacitor and enables to improve smaller set and long-life.

Features

- AEC-Q100 Qualified^(Note 1)
- High Accuracy Reference Voltage Circuit
- Built-in Over Current Protection Circuit (OCP)
- Built-in Thermal Shut Down Circuit (TSD)
- With Shutdown Switch (Note 1) Grade2

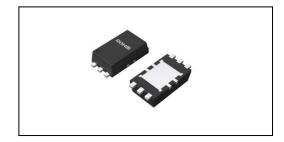
Application

■ Automotive (Body)

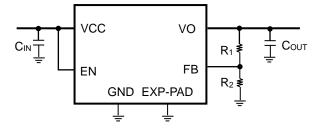
Key Specifications

Input Power Supply Voltage Range: 2.4V to 5.5V
 Output Voltage Range(Variable type): 0.8V to 4.5V
 Output Current: 0.5A (Max)
 Shutdown Current: 0µA(Typ)
 Ambient Temperature Range Ta: -40°C to +105°C

Package W(Typ) x D(Typ) x H(Max) HVSOF6 1.60mm x 3.00mm x 0.75mm



Typical Application Circuit



CIN, COUT: Ceramic Capacitor

Figure 1. Application Circuit

Contents

Gene	eral Descriptioneral Description	1
Featu	tures	1
Key S	Specifications	1
Pack	kage W(Typ) x D(Typ) x H(Max)	1
Typic	ical Application Circuit	1
Conte	tents	2
Pin C	Configuration	3
Pin D	Description	3
Block	ck Diagram	3
Abso	olute Maximum Ratings	4
Opera	rating Conditions	4
Elect	ctrical Characteristics	4
Therr	rmal Resistance ^(Note 1)	5
Typic	ical Performance Curves	6
	ver Dissipation	
Therr	rmal Design	16
	ıt-to-Output Capacitor	
	Equivalent circuits	
	ear Regulators Surge Voltage Protection	
	pplying Positive Surge to the Input	
Ap	pplying Negative Surge to the input	20
	ear Regulators Reverse Voltage Protection	
	everse Input /Output Voltage	
Pro	rotection against Input Reverse Voltage	21
	rotection against Output Reverse Voltage when Output Connect to an Inductor	
Opera	rational Notes	23
1.		
2.		
3.		
4.	•·•···································	
5.		
6.	Inrush Current	23
7.		
8.	p	
9.		
10.	· · · · · · · · · · · · · · · · · · ·	
11.		24
12.		24
13.		
Orde	ering Information	25
	king Diagram	
	sical Dimension and Packing Information	
Revis	ision History	27

Pin Configuration

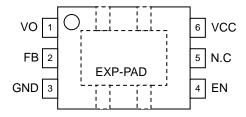


Figure 2. HVSOF6 (TOP VIEW)

Pin Description

Pin No.	Pin name	Pin Function
1	VO	Output pin
2	FB	Feedback pin
3	GND	GND pin
4	EN	Enable pin
5	N.C ^(Note 1)	Non Connection (Used to connect GND or OPEN state.)
6	VCC	Input pin
Reverse	EXP-PAD	GND

(Note 1) N.C. pin can be opened because it isn't connected it inside of IC.

Block Diagram

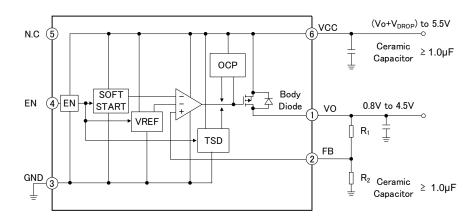


Figure 3. Block Diagram

Absolute Maximum Ratings

Parameter	Symbol	Limits	Unit
i alametei	Symbol	15	Offic
Power Supply Voltage	Vcc	-0.3 to +7.0 ^(Note 1)	V
EN Voltage	V _{EN}	-0.3 to +7.0	V
Storage Temperature Range	Tstg	-55 to +150	°C
Maximum Junction Temperature	Tjmax	+150	°C

Caution 1: Operating the IC over the absolute maximum ratings may damage the IC. The damage can either be a short circuit between pins or an open circuit between pins and the internal circuitry. Therefore, it is important to consider circuit protection measures, such as adding a fuse, in case the IC is operated over the absolute maximum ratings.

protection measures, such as adding a fuse, in case the IC is operated over the absolute maximum ratings.

Caution 2:Should by any chance the maximum junction temperature rating be exceeded the rise in temperature of the chip may result in deterioration of the properties of the chip. In case of exceeding this absolute maximum rating, design a PCB boards with thermal resistance and power dissipation taken into consideration by increasing board size and copper area so as not to exceed the maximum junction temperature rating.

(Note 1) Not to exceed Tjmax

Operating Conditions

Parameter	Symbol	Min	Max	Unit
Input Power Supply Voltage	Vcc	2.4	5.5	V
Operating Temperature	Ta	-40	+105	°C
EN Voltage	V _{EN}	0.0	5.5	V
Output Voltage Setting Range	Vo	0.8	4.5	V
Output Current	lo	0.0	0.5	Α
Input Capacitor	Cin	1.0 ^(Note 2)	-	μF
Output Capacitor	Соит	1.0 ^(Note 2)	-	μF

(Note 2) Set the value of the capacitor so that it does not fall below the minimum value.

Take into consideration the temperature characteristics, DC device characteristics and degradation with time.

Electrical Characteristics

(Unless otherwise noted, Ta=-40°C to +105°C, EN=3V, V_{CC} =3.3V, R_1 =16k Ω , R_2 =7.5k Ω)

Parameter	Symbol	Min	Typ	Max	Unit	Conditions
Circuit Current at Shutdown Mode	I _{SD}	-	0	5	μA	EN=0V, OFF mode
Bias Current	Icc	-	250	700	μA	
Line Regulation	Reg.I	-1.0	-	+1.0	%	Vcc =(Vo+0.6V) to 5.5V
Load Regulation	Reg.Io	-1.5	-	+1.5	%	I _O =0 to 500mA
Minimum Dropout Voltage	V _{DROP}	-	0.40	0.70	V	V _{CC} =3.3V, I _O =500mA
Output Reference Voltage (Variable type)	V _{FB}	0.776	0.800	0.824	V	Io=0mA
EN Low Voltage	V _{EN} (Low)	0	-	0.8	V	
EN High Voltage	V _{EN} (High)	2.4	-	5.5	V	
EN Bias Current	len	-	3	9	μA	

Thermal Resistance^(Note 1)

Deremeter	Symbol	Thermal Resistance (Typ)		l limit
Parameter		1s ^(Note 3)	2s2p ^(Note 4)	Unit
HVSOF6				
Junction to Ambient	θја	283.8	65.2	°C/W
Junction to Top Characterization Parameter ^(Note 2)	Ψ_{JT}	35	16	°C/W

(Note 1) Based on JESD51-2A(Still-Air).

(Note 3) Using a PCB board based on JESD51-3.

(Note 4) Using a PCB board based on JESD51-5. 7.

Layer Number of Measurement Board	Material	Board Size
Single	FR-4	114.3 mm x 76.2 mm x 1.57 mmt

Тор			
Copper Pattern	Thickness		
Footprints and Traces	70 µm		

Layer Number of	Material	Board Sizo	Board Size		(Note 5)
Measurement Board	Material	114.3 mm x 76.2 mm x 1.6 mmt		Pitch	Diameter
4 Layers	FR-4			1.20 mm	Ф0.30 mm
Тор		2 Internal Layers		Bottom	
Copper Pattern Thickness		Copper Pattern	Thickness	Copper Pattern	Thickness
Footprints and Traces	70 µm	74.2 mm x 74.2 mm	35 µm	74.2 mm x 74.2 mm	n 70 µm

(Note 5) This thermal via connects with the copper pattern of all layers.

Typical Performance Curves

(Unless otherwise noted, EN=3V, V_{CC} =3.3V, R_1 =16k Ω , R_2 =7.5k Ω)

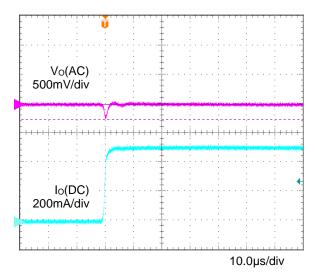


Figure 4. Transient Response (Io:1mA to 500mA) (CIN=COUT=1µF, Ta=-40°C)

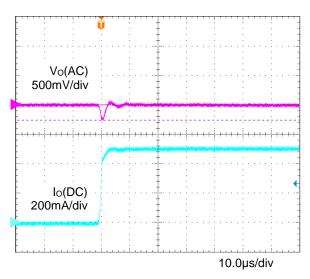


Figure 5. Transient Response (Io:1mA to 500mA) (C_{IN}=C_{OUT}=1µF, Ta=+25°C)

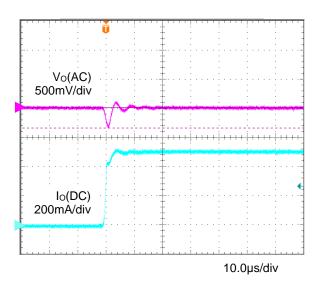


Figure 6. Transient Response (Io:1mA to 500mA) (C_{IN}=C_{OUT}=1µF, Ta=+105°C)

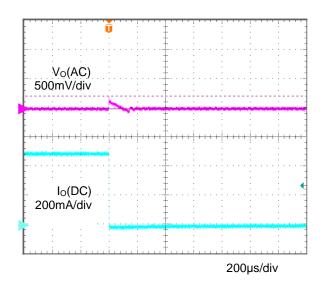


Figure 7. Transient Response (Io:500mA to 1mA) (CIN=COUT=1µF, Ta=-40°C)

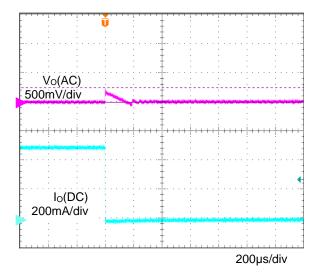


Figure 8. Transient Response (Io:500mA to 1mA) (C_{IN}=C_{OUT}=1µF, Ta=+25°C)

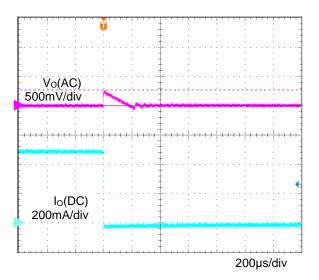


Figure 9. Transient Response (Io:500mA to 1mA) (CIN=COUT=1µF, Ta=+105°C)

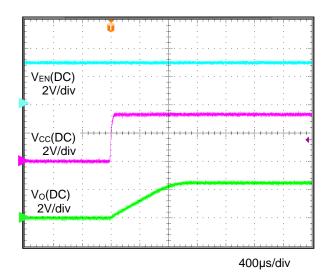


Figure 10. Input sequence 1 (Vcc:0V to 3.3V) ($C_{IN}=C_{OUT}=1\mu F, Ta=-40^{\circ}C, tr=30\mu s$)

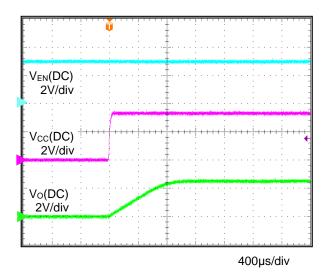


Figure 11. Input sequence 1 (Vcc:0V to 3.3V) ($C_{IN}=C_{OUT}=1\mu F$, $Ta=+25^{\circ}C$, $tr=30\mu s$)

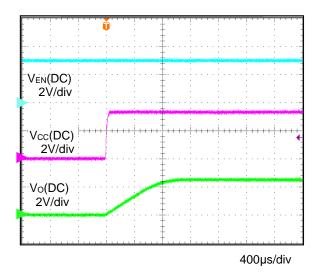


Figure 12. Input sequence 1 (Vcc:0V to 3.3V) $(C_{\text{IN}} = C_{\text{OUT}} = 1 \mu\text{F}, Ta = +105 ^{\circ}\text{C}, tr = 30 \mu\text{s})$

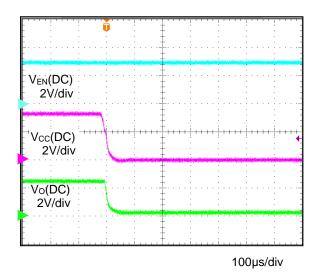


Figure 13. OFF sequence 1 (Vcc:3.3V to 0V) ($C_{IN}=C_{OUT}=1\mu F$, $Ta=-40^{\circ}C$, $tf=30\mu s$)

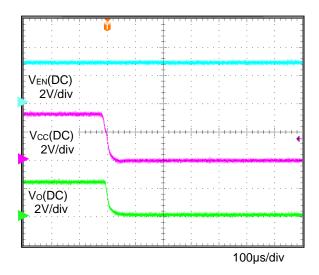


Figure 14. OFF sequence 1 (Vcc:3.3V to 0V) ($C_{IN}=C_{OUT}=1\mu F$, $Ta=+25^{\circ}C$, $tf=30\mu s$)

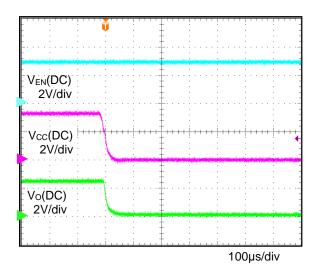


Figure 15. OFF sequence 1 (Vcc:3.3V to 0V) ($C_{IN}=C_{OUT}=1\mu F$, $Ta=+150^{\circ}C$, $tf=30\mu s$)

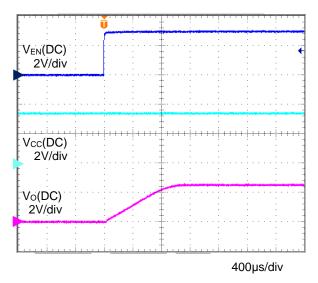


Figure 16. Input sequence 2 (EN:0V to 3V) ($C_{IN}=C_{OUT}=1\mu F$, $Ta=-40^{\circ}C$, $tr=20\mu s$)

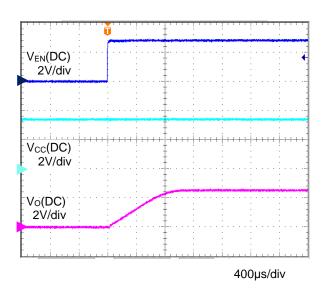


Figure 17. Input sequence 2 (EN:0V to 3V) ($C_{IN}=C_{OUT}=1\mu F$, $T_{a}=+25^{\circ}C$, $t_{a}=20\mu s$)

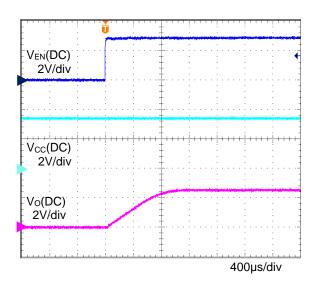


Figure 18. Input sequence 2 (EN:0V to 3V) $(C_{\text{IN}} = C_{\text{OUT}} = 1 \mu \text{F}, Ta = +125 ^{\circ}\text{C}, tr = 20 \mu \text{s})$

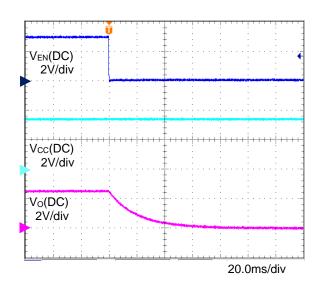


Figure 19. OFF sequence 2 (EN:3V to 0V) ($C_{IN}=C_{OUT}=1\mu F$, $Ta=-40^{\circ}C$, $tf=20\mu s$)

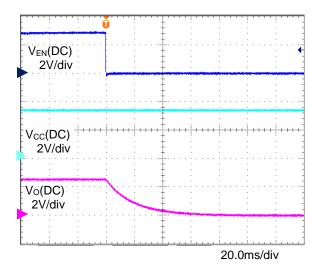


Figure 20. OFF sequence 2 (EN:3V to 0V) ($C_{IN}=C_{OUT}=1\mu F$, $T_{a}=+25^{\circ}C$, $t_{f}=20\mu s$)

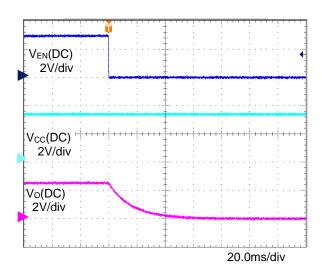


Figure 21. OFF sequence 2 (EN:3V to 0V) ($C_{IN}=C_{OUT}=1\mu F$, $Ta=+105^{\circ}C$, $tf=20\mu s$)

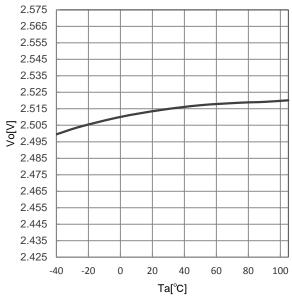


Figure 22. Vo vs Ta (Io=0mA)

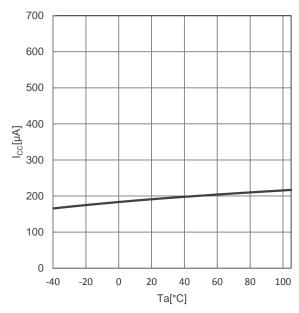


Figure 23. Icc vs Ta

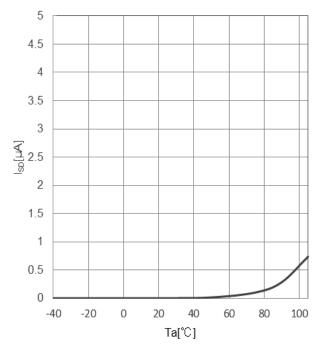


Figure 24. I_{SD} vs Ta (V_{EN}=0V)

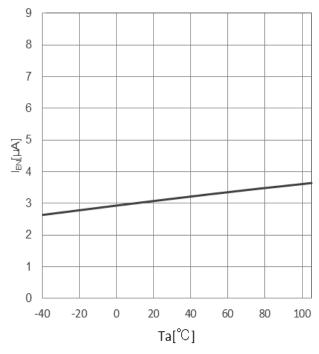


Figure 25. I_{EN} vs Ta

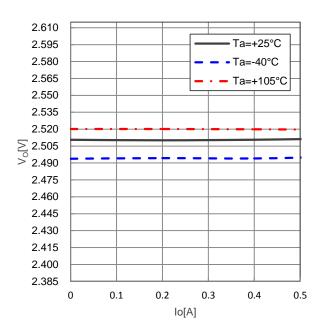


Figure 26. Vo vs Io

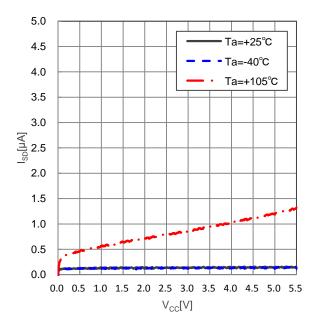


Figure 27. I_{SD} vs V_{CC} (V_{EN}=0V)

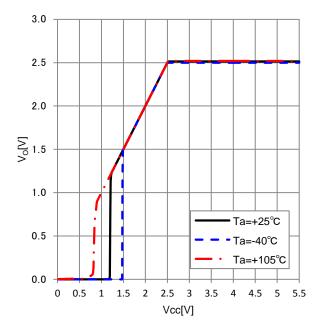


Figure 28. V_0 vs V_{CC} (Io=0mA)

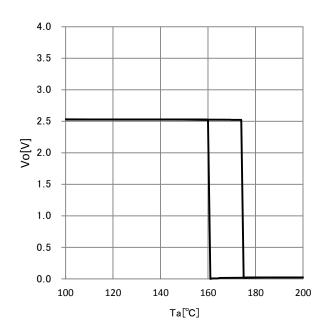


Figure 29. Vo vs Ta TSD (Io=0mA)

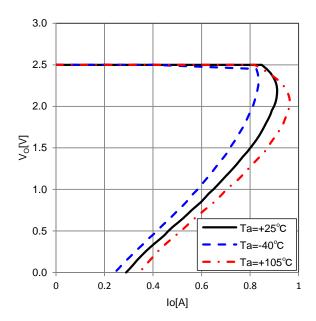


Figure 30. V_0 vs I_0

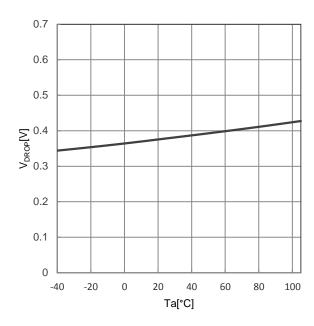


Figure 31. V_{DROP} vs Ta (V_{CC} =3.3V, I_{O} =0.5A, V_{FB} =0V)

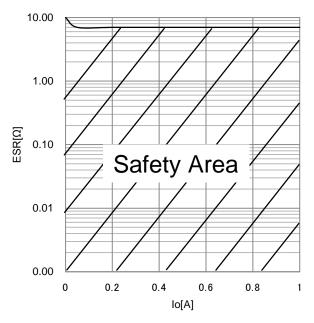


Figure 32. ESR vs Io (Operation Safety area) (-40 °C \leq Ta \leq +105 °C) (2.4V \leq Vcc \leq 5.5V, CIN=COUT=1 μ F)

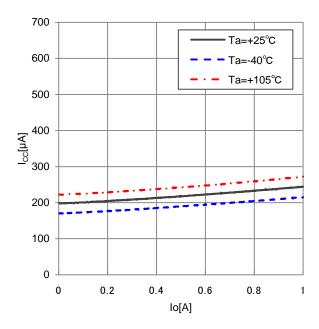


Figure 33. Icc vs lo

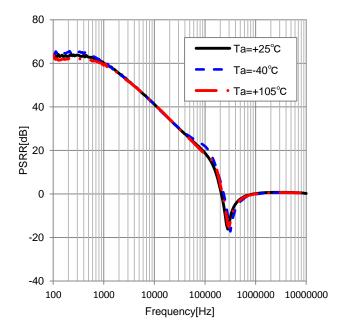


Figure 34. PSRR vs Frequency (ein=50mVpp, I_0 =100mA, C_{OUT} =1 μ F)

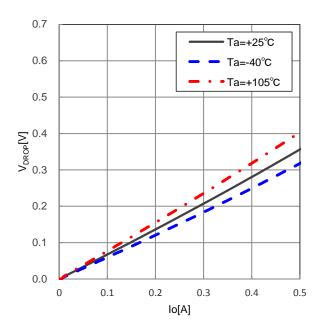


Figure 35. V_{DROP} vs Io $(V_{CC}=2.4V, V_{FB}=0V)$

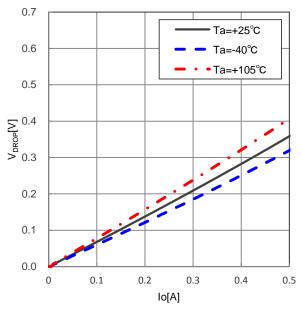


Figure 36. V_{DROP} vs Io $(V_{CC}=3.3V, V_{FB}=0V)$

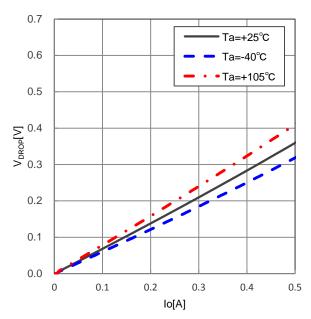


Figure 37. V_{DROP} vs Io $(V_{CC}=4V, V_{FB}=0V)$

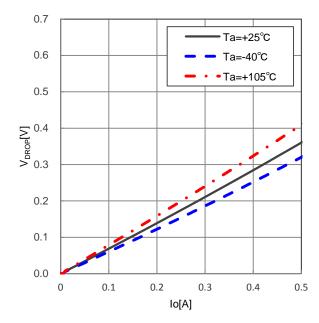


Figure 38. V_{DROP} vs Io (V_{CC}=5.5V, V_{FB}=0V)

Power Dissipation

■HVSOF6

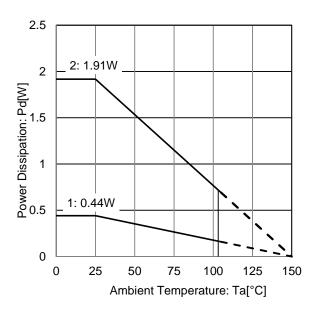


Figure 39. HVSOF6 Power Dissipation Graph (Reference Data)

IC mounted on ROHM standard board based on JEDEC.

1:1-layer PCB

(Copper foil area on the reverse side of PCB: 0mm x 0mm)

Board material: FR4

Board size: 114.3mm x 76.2mm x 1.57mmt

Mount condition: PCB and exposed pad are soldered. Top copper foil: ROHM recommended footprint

+ wiring to measure, 2 oz. copper.

2: 4-layer PCB

(Copper foil area on the reverse side of PCB: 74.2mm x 74.2mm)

Board material: FR4

Board size: 114.3mm × 76.2mm × 1.60mmt

Mount condition: PCB and exposed pad are soldered. Top copper foil: ROHM recommended footprint

+ wiring to measure, 2 oz. copper. 2 inner layers copper foil area of PCB:

74.2mm x 74.2mm, 1 oz. copper.
Copper foil area on the reverse side of PCB:

74.2mm × 74.2mm, 2 oz. copper.

Condition 1 : θ_{JA} = 283.8 °C/W, Ψ_{JT} (top center) = 35°C/W Condition 2 : θ_{JA} = 65.2°C/W, Ψ_{JT} (top center) = 16°C/W

Thermal Design

Within this product, the power consumption is decided by the dropout voltage condition, the load current and the circuit current. Refer to Package Data illustrated in Figure 39 when using the IC in an environment of Ta \geq 25 °C. Even if the ambient temperature Ta is at 25 °C, depending on the input voltage and the load current, chip junction temperature can be very high. Consider the design to be Tj \leq Tjmax = 150 °C in all possible operating temperature range. On the reverse side of the package (HVSOF6) there is exposed heat pad for improving the heat dissipation.

Should by any condition the maximum junction temperature Tjmax = 150 °C rating be exceeded by the temperature increase of the chip, it may result in deterioration of the properties of the chip. The thermal impedance in this specification is based on recommended PCB and measurement condition by JEDEC standard. Verify the application and allow sufficient margins in the thermal design by the following method is used to calculate the junction temperature Tj. Tj can be calculated by either of the two following methods.

1. The following method is used to calculate the Tj: Junction Temperature from Ta: Ambient Temperature.

$$Tj = Ta + P_C \times \theta_{IA}$$

Where:

Tj : Junction Temperature Ta : Ambient Temperature $P_{\mathcal{C}}$: Power Consumption $\theta_{J\!A}$: Thermal Impedance (Junction to Ambient)

2. The following method is also used to calculate the Tj: Junction Temperature from T_T: top Center of Case's (mold) Temperature.

$$T_i = T_T + P_C \times \Psi_{iT}$$

Where:

Tj : Junction Temperature

 T_T : Top Center of Case's (mold) Temperature

 P_C : Power consumption ψ_{JT} : Thermal Impedance

(Junction to Top Center of Case)

The following method is used to calculate the power consumption Pc (W) from input and output voltage, output current and circuit current.

$$Pc = (Vcc - Vo) \times Io + Vcc \times Icc$$

Where:

 $P_{\mathcal{C}}$: Power Consumption

Vcc : Input Voltage
Vo : Output Voltage
Io : Output Current
Icc : Circuit Current

Thermal Design - continued

If $V_{CC} = 5.0 \text{ V}$, $V_O = 3.3 \text{ V}$, $I_O = 0.1 \text{ A}$, $I_{CC} = 250 \text{ }\mu\text{A}$, the power consumption Pc can be calculated as follows:

$$Pc = (Vcc - Vo) \times Io + Vcc \times Icc$$

= $(5.0 \text{ V} - 3.3 \text{ V}) \times 0.1 \text{ A} + 5.0 \text{ V} \times 250 \mu A$
= 0.17125 W

At the ambient temperature Tamax = 105°C, the thermal Impedance (Junction to Ambient) θ_{JA} = 65.2 °C / W (4-layer PCB),

$$Tj = Tamax + P_C \times \theta_{JA}$$

= 105 °C + 0.17125 W × 65.2 °C / W
= 116.2 °C

When operating the IC, the top center of case's (mold) temperature $T_T = 100$ °C, $\Psi_{JT} = 16$ °C / W (4-layer PCB),

$$Tj = T_T + P_C \times \Psi_{JT}$$

= 100 °C + 0.17125 W × 16 °C / W
= 102.7 °C

For optimum thermal performance, it is recommended to expand the copper foil area of the board, increasing the layer and thermal via between thermal land pad.

Input-to-Output Capacitor

It is recommended that a capacitor is placed nearby pin between Input pin and GND, output pin and GND.

A capacitor, between input pin and GND, is valid when the power supply impedance is high or drawing is long. Also as for a capacitor, between output pin and GND, the greater the capacity, more sustainable the line regulation and it makes improvement of characteristics by load change. However, check by mounted on a board for the actual application. Ceramic capacitor usually has difference, thermal characteristics and series bias characteristics, and moreover capacity decreases gradually by using conditions.

For more detail, be sure to inquire the manufacturer, and select the best ceramic capacitor.

Equivalent Series Resistance ESR

In order to prevent oscillation, a capacitor needs to be placed between the output pin and GND. Generally, Capacitor has ESR (Equivalent Series Resistance). This product works stable in a specific ESR area.

Refer to ESR vs I_0 characteristics data regarding safety area. This reference measurement data condition is output ceramic capacitor (1.0 μ F) connected resistor in series.

Generally, there is difference in ESR value among electrolytic, tantalum and ceramic capacitors. It recommends confirming ESR value is in safety area of ESR vs lo characteristics graph.

Provided however, the stable domain of this graph is based on the measurement result from single IC on our board with resistive load. In the actual environment, stability is affected by wire impedance on the board, input power supply impedance and load impedance, therefore it is strongly recommended thorough verification in the actual usage environment.

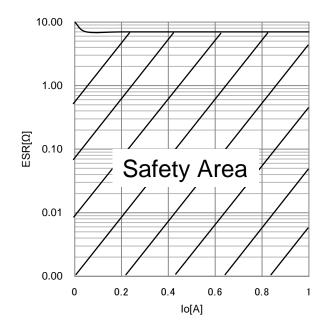
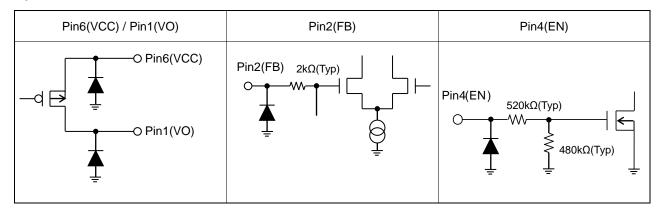


Figure 40. ESR vs I_0 characteristics (-40 °C \leq Ta \leq +105 °C) (2.4V \leq Vcc \leq 5.5V, CIN=COUT=1 μ F)

I/O Equivalent circuits



Linear Regulators Surge Voltage Protection

In the following, it explains the protection method for ICs when surge exceed absolute maximum ratings is applied to the input.

Applying Positive Surge to the Input

If the positive surge that exceeds absolute maximum ratings 7 V is applied to the input, a Zener Diode should be placed to protect the device in between the IN and the GND as shown in the figure 41.

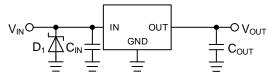


Figure 41. Surges Higher than 7 V is Applied to the Input

Applying Negative Surge to the input

If the negative surge that exceeds absolute maximum ratings -0.3V is applied to the input, a Schottky Diode should be place to protect the device in between the IN and the GND as shown in the figure 42.

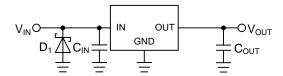


Figure 42. Surges Lower than -0.3 V is Applied to the Input

Linear Regulators Reverse Voltage Protection

A linear regulator integrated circuit (IC) requires that the input voltage is always higher than the output voltage. Output voltage, however, may become higher than the input voltage under specific situations or circuit configurations, and that reverse voltage and current may cause damage to the IC. A reverse polarity connection or certain inductor components can also cause a polarity reversal between the input and output pins. In the following, it explains the protection method for ICs when a condition of voltage reverses.

Reverse Input /Output Voltage

In a MOS linear regulator, a body diode exists as a parasitic element in the drain-source junction portion of its power MOSFET. Reverse input/output voltage triggers the current flow from the output to the input through the body diode. The inverted current may damage or destroy the semiconductor elements of the regulator since the effect of the parasitic body diode is not guaranteed the operation (Figure 43).

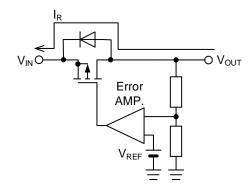


Figure 43. Reverse Current Path in a MOS Linear Regulator

Reverse Input /Output Voltage -continued

An effective solution to this is to connect an external bypass diode connected in-between the input and output to prevent the reverse current from flowing inside the IC (see Figure 44). Note that the bypass diode must be turned on before the internal circuit of the IC. Bypass diodes in the internal circuits of MOS linear regulators must have low forward voltage V_F. When the reverse current from this bypass diode is large, leakage current of the diode flows a lot from the input to the output even if it turns off the output with IC the shutdown function; therefore, it is necessary to choose one that has a small reverse current. Specifically, select a diode with a rated reverse voltage greater than the input to output voltage differential and rated forward current greater than the reverse current.

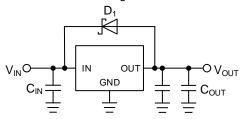


Figure 44. Bypass Diode for Reverse Current Diversion

The lower forward voltage (V_F) of Schottky barrier diodes cater to requirements of MOS linear regulators, however the main drawback is that their reverse current (I_R), which is relatively high. So, one with a low reverse current is recommended when choosing a Schottky diode. The V_{R} - I_R characteristics versus temperatures show increases at higher temperatures. It is recommended that confirming the datasheet for Schottky barrier diodes.

If V_{IN} is open in a circuit as shown in the following Figure 45 with its input/output voltage being reversed, the only current that flows in the reverse current path is the bias current of the IC. Because the amperage is too low to damage or destroy the parasitic element, a reverse current bypass diode is not required for this type of circuit.

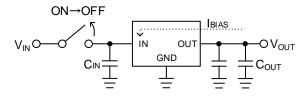


Figure 45. Open VIN

Protection against Input Reverse Voltage

Accidental reverse polarity at the input connection flows a large current to the diode for electrostatic breakdown protection between the input pin of the IC and the GND pin, which may destroy the IC (see Figure 46).

A Schottky barrier diode or rectifier diode connected in series with the power supply as shown in Figure 47 is the simplest solution to prevent this from happening. There is a power loss calculated as $V_{F\,x}$ I_{OUT} , as the forward voltage V_F of the diode drops in a correct connection. The lower V_F of a Schottky barrier diode than that of a rectifier diode gives a slightly smaller power loss. Because diodes generate heat, select a diode that has enough allowance in power dissipation. A reverse connection allows a negligible reverse current to flow in the diode.

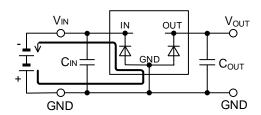


Figure 46. Current Path in Reverse Input Connection

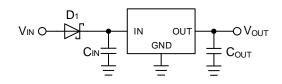


Figure 47. Protection against Reverse Polarity 1

Protection against Input Reverse Voltage -continued

Figure 48 shows a circuit in which a P-channel MOSFET is connected in series with the power. The diode located in the drain-source junction portion of the MOSFET is a body diode (parasitic element). The voltage drop in a correct connection is calculated by multiplying the resistance of the MOSFET being turned on by the output current lout, therefore it is smaller than the voltage drop by the diode (see Figure 48) and results in less of a power loss. No current flows in a reverse connection where the MOSFET remains off.

If the voltage taking account of derating is greater than the voltage rating of MOSFET gate-source junction, lower the gate-source junction voltage by connecting voltage dividing resistors as shown in Figure 49.

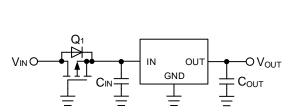


Figure 48. Protection against Reverse Polarity 2

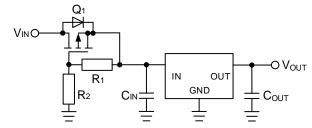


Figure 49. Protection against Reverse Polarity 3

Protection against Output Reverse Voltage when Output Connect to an Inductor

If the output load is inductive, electrical energy accumulated in the inductive load is released to the ground upon the output voltage turning off. In-between the IC output and ground pin is a diode for preventing electrostatic breakdown, in which a large current flows that could destroy the IC. To prevent this from happening, connect a Schottky barrier diode in parallel with the diode (see Figure 50).

Further, if a long wire is in use for the connection between the output pin of the IC and the load, observe the waveform on an oscilloscope, since it is possible that the load becomes inductive. An additional diode is needed for a motor load because a similar electric current flows by its counter electromotive force.

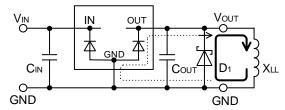


Figure 50. Current Path in Inductive Load (Output: Off)

Operational Notes

1. Reverse Connection of Power Supply

Connecting the power supply in reverse polarity can damage the IC. Take precautions against reverse polarity when connecting the power supply, such as mounting an external diode between the power supply and the IC's power supply pins.

2. Power Supply Lines

Design the PCB layout pattern to provide low impedance supply lines. Furthermore, connect a capacitor to ground at all power supply pins. Consider the effect of temperature and aging on the capacitance value when using electrolytic capacitors.

3. Ground Voltage

Ensure that no pins are at a voltage below that of the ground pin at any time, even during transient condition.

4. Ground Wiring Pattern

When using both small-signal and large-current ground traces, the two ground traces should be routed separately but connected to a single ground at the reference point of the application board to avoid fluctuations in the small-signal ground caused by large currents. Also ensure that the ground traces of external components do not cause variations on the ground voltage. The ground lines must be as short and thick as possible to reduce line impedance.

5. Operating Conditions

The function and operation of the IC are guaranteed within the range specified by the operating conditions. The characteristic values are guaranteed only under the conditions of each item specified by the electrical characteristics.

6. Inrush Current

When power is first supplied to the IC, it is possible that the internal logic may be unstable and inrush current may flow instantaneously due to the internal powering sequence and delays, especially if the IC has more than one power supply. Therefore, give special consideration to power coupling capacitance, power wiring, width of ground wiring, and routing of connections.

7. Testing on Application Boards

When testing the IC on an application board, connecting a capacitor directly to a low-impedance output pin may subject the IC to stress. Always discharge capacitors completely after each process or step. The IC's power supply should always be turned off completely before connecting or removing it from the test setup during the inspection process. To prevent damage from static discharge, ground the IC during assembly and use similar precautions during transport and storage.

8. Inter-pin Short and Mounting Errors

Ensure that the direction and position are correct when mounting the IC on the PCB. Incorrect mounting may result in damaging the IC. Avoid nearby pins being shorted to each other especially to ground, power supply and output pin. Inter-pin shorts could be due to many reasons such as metal particles, water droplets (in very humid environment) and unintentional solder bridge deposited in between pins during assembly to name a few.

9. Unused Input Pins

Input pins of an IC are often connected to the gate of a MOS transistor. The gate has extremely high impedance and extremely low capacitance. If left unconnected, the electric field from the outside can easily charge it. The small charge acquired in this way is enough to produce a significant effect on the conduction through the transistor and cause unexpected operation of the IC. So unless otherwise specified, unused input pins should be connected to the power supply or ground line.

Operational Notes - continued

10. Regarding the Input Pin of the IC

This monolithic IC contains P+ isolation and P substrate layers between adjacent elements in order to keep them isolated. P-N junctions are formed at the intersection of the P layers with the N layers of other elements, creating a parasitic diode or transistor. For example (refer to figure below):

When GND > Pin A and GND > Pin B, the P-N junction operates as a parasitic diode. When GND > Pin B, the P-N junction operates as a parasitic transistor.

Parasitic diodes inevitably occur in the structure of the IC. The operation of parasitic diodes can result in mutual interference among circuits, operational faults, or physical damage. Therefore, conditions that cause these diodes to operate, such as applying a voltage lower than the GND voltage to an input pin (and thus to the P substrate) should be avoided.

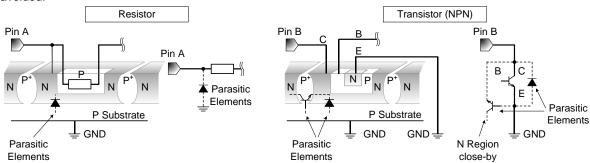


Figure 51. Example of monolithic IC structure

11. Ceramic Capacitor

When using a ceramic capacitor, determine a capacitance value considering the change of capacitance with temperature and the decrease in nominal capacitance due to DC bias and others.

12. Thermal Shutdown Circuit(TSD)

This IC has a built-in thermal shutdown circuit that prevents heat damage to the IC. Normal operation should always be within the IC's maximum junction temperature rating. If however the rating is exceeded for a continued period, the junction temperature (Tj) will rise which will activate the TSD circuit that will turn OFF power output pins. When the Tj falls below the TSD threshold, the circuits are automatically restored to normal operation.

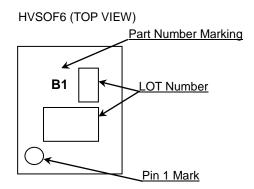
Note that the TSD circuit operates in a situation that exceeds the absolute maximum ratings and therefore, under no circumstances, should the TSD circuit be used in a set design or for any purpose other than protecting the IC from heat damage.

13. Over Current Protection Circuit (OCP)

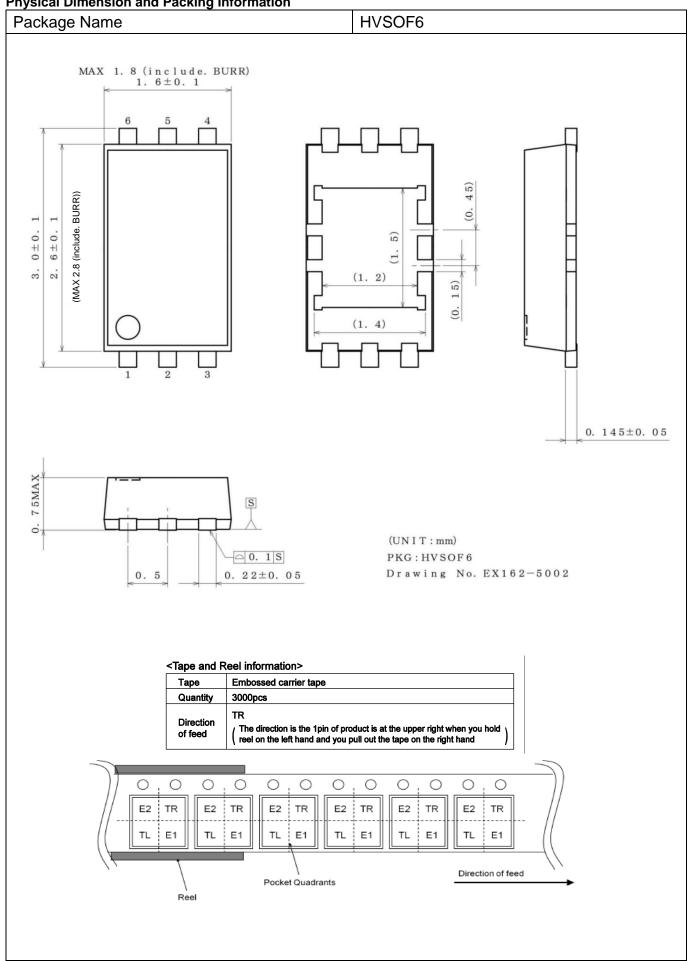
This IC incorporates an integrated overcurrent protection circuit that is activated when the load is shorted. This protection circuit is effective in preventing damage due to sudden and unexpected incidents. However, the IC should not be used in applications characterized by continuous operation or transitioning of the protection circuit.

Ordering Information В 0 I Α 5 M Н F Μ Τ R D 0 Part Output Voltag Output Characteristic Package Packaging and Number voltage current forming specification е M: Automotive Grade resista HFV:HVSOF6 M:Automotive 00:Variable A5:0.5A TR: Emboss tape reel nce I:7V

Marking Diagram



Physical Dimension and Packing Information



Revision History

Date	Revision	Changes
14.Mar.2018	001	New release

Notice

Precaution on using ROHM Products

1. If you intend to use our Products in devices requiring extremely high reliability (such as medical equipment (Note 1), aircraft/spacecraft, nuclear power controllers, etc.) and whose malfunction or failure may cause loss of human life, bodily injury or serious damage to property ("Specific Applications"), please consult with the ROHM sales representative in advance. Unless otherwise agreed in writing by ROHM in advance, ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of any ROHM's Products for Specific Applications.

(Note1) Medical Equipment Classification of the Specific Applications

(camen or and open		
JAPAN	USA	EU	CHINA
CLASSⅢ	CLASSIII	CLASS II b	CLASSⅢ
CLASSIV	CLASSIII	CLASSⅢ	CLASSIII

- 2. ROHM designs and manufactures its Products subject to strict quality control system. However, semiconductor products can fail or malfunction at a certain rate. Please be sure to implement, at your own responsibilities, adequate safety measures including but not limited to fail-safe design against the physical injury, damage to any property, which a failure or malfunction of our Products may cause. The following are examples of safety measures:
 - [a] Installation of protection circuits or other protective devices to improve system safety
 - [b] Installation of redundant circuits to reduce the impact of single or multiple circuit failure
- 3. Our Products are not designed under any special or extraordinary environments or conditions, as exemplified below. Accordingly, ROHM shall not be in any way responsible or liable for any damages, expenses or losses arising from the use of any ROHM's Products under any special or extraordinary environments or conditions. If you intend to use our Products under any special or extraordinary environments or conditions (as exemplified below), your independent verification and confirmation of product performance, reliability, etc, prior to use, must be necessary:
 - [a] Use of our Products in any types of liquid, including water, oils, chemicals, and organic solvents
 - [b] Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
 - [c] Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl₂, H₂S, NH₃, SO₂, and NO₂
 - [d] Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
 - [e] Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
 - [f] Sealing or coating our Products with resin or other coating materials
 - [g] Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
 - [h] Use of the Products in places subject to dew condensation
- 4. The Products are not subject to radiation-proof design.
- 5. Please verify and confirm characteristics of the final or mounted products in using the Products.
- 6. In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- 7. De-rate Power Dissipation depending on ambient temperature. When used in sealed area, confirm that it is the use in the range that does not exceed the maximum junction temperature.
- 8. Confirm that operation temperature is within the specified range described in the product specification.
- ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

Precaution for Mounting / Circuit board design

- 1. When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
- 2. In principle, the reflow soldering method must be used on a surface-mount products, the flow soldering method must be used on a through hole mount products. If the flow soldering method is preferred on a surface-mount products, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

Precautions Regarding Application Examples and External Circuits

- 1. If change is made to the constant of an external circuit, please allow a sufficient margin considering variations of the characteristics of the Products and external components, including transient characteristics, as well as static characteristics.
- You agree that application notes, reference designs, and associated data and information contained in this document are presented only as guidance for Products use. Therefore, in case you use such information, you are solely responsible for it and you must exercise your own independent verification and judgment in the use of such information contained in this document. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of such information.

Precaution for Electrostatic

This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of lonizer, friction prevention and temperature / humidity control).

Precaution for Storage / Transportation

- 1. Product performance and soldered connections may deteriorate if the Products are stored in the places where:
 - [a] the Products are exposed to sea winds or corrosive gases, including Cl2, H2S, NH3, SO2, and NO2
 - [b] the temperature or humidity exceeds those recommended by ROHM
 - [c] the Products are exposed to direct sunshine or condensation
 - [d] the Products are exposed to high Electrostatic
- Even under ROHM recommended storage condition, solderability of products out of recommended storage time period
 may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is
 exceeding the recommended storage time period.
- 3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
- 4. Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

Precaution for Product Label

A two-dimensional barcode printed on ROHM Products label is for ROHM's internal use only.

Precaution for Disposition

When disposing Products please dispose them properly using an authorized industry waste company.

Precaution for Foreign Exchange and Foreign Trade act

Since concerned goods might be fallen under listed items of export control prescribed by Foreign exchange and Foreign trade act, please consult with ROHM in case of export.

Precaution Regarding Intellectual Property Rights

- 1. All information and data including but not limited to application example contained in this document is for reference only. ROHM does not warrant that foregoing information or data will not infringe any intellectual property rights or any other rights of any third party regarding such information or data.
- 2. ROHM shall not have any obligations where the claims, actions or demands arising from the combination of the Products with other articles such as components, circuits, systems or external equipment (including software).
- 3. No license, expressly or implied, is granted hereby under any intellectual property rights or other rights of ROHM or any third parties with respect to the Products or the information contained in this document. Provided, however, that ROHM will not assert its intellectual property rights or other rights against you or your customers to the extent necessary to manufacture or sell products containing the Products, subject to the terms and conditions herein.

Other Precaution

- 1. This document may not be reprinted or reproduced, in whole or in part, without prior written consent of ROHM.
- 2. The Products may not be disassembled, converted, modified, reproduced or otherwise changed without prior written consent of ROHM.
- In no event shall you use in any way whatsoever the Products and the related technical information contained in the Products or this document for any military purposes, including but not limited to, the development of mass-destruction weapons.
- 4. The proper names of companies or products described in this document are trademarks or registered trademarks of ROHM, its affiliated companies or third parties.

Notice-PAA-E Rev.003

General Precaution

- 1. Before you use our Products, you are requested to carefully read this document and fully understand its contents. ROHM shall not be in any way responsible or liable for failure, malfunction or accident arising from the use of any ROHM's Products against warning, caution or note contained in this document.
- 2. All information contained in this document is current as of the issuing date and subject to change without any prior notice. Before purchasing or using ROHM's Products, please confirm the latest information with a ROHM sales representative.
- 3. The information contained in this document is provided on an "as is" basis and ROHM does not warrant that all information contained in this document is accurate and/or error-free. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties resulting from inaccuracy or errors of or concerning such information.

Notice – WE Rev.001